

Fault Attacks on Signature Schemes

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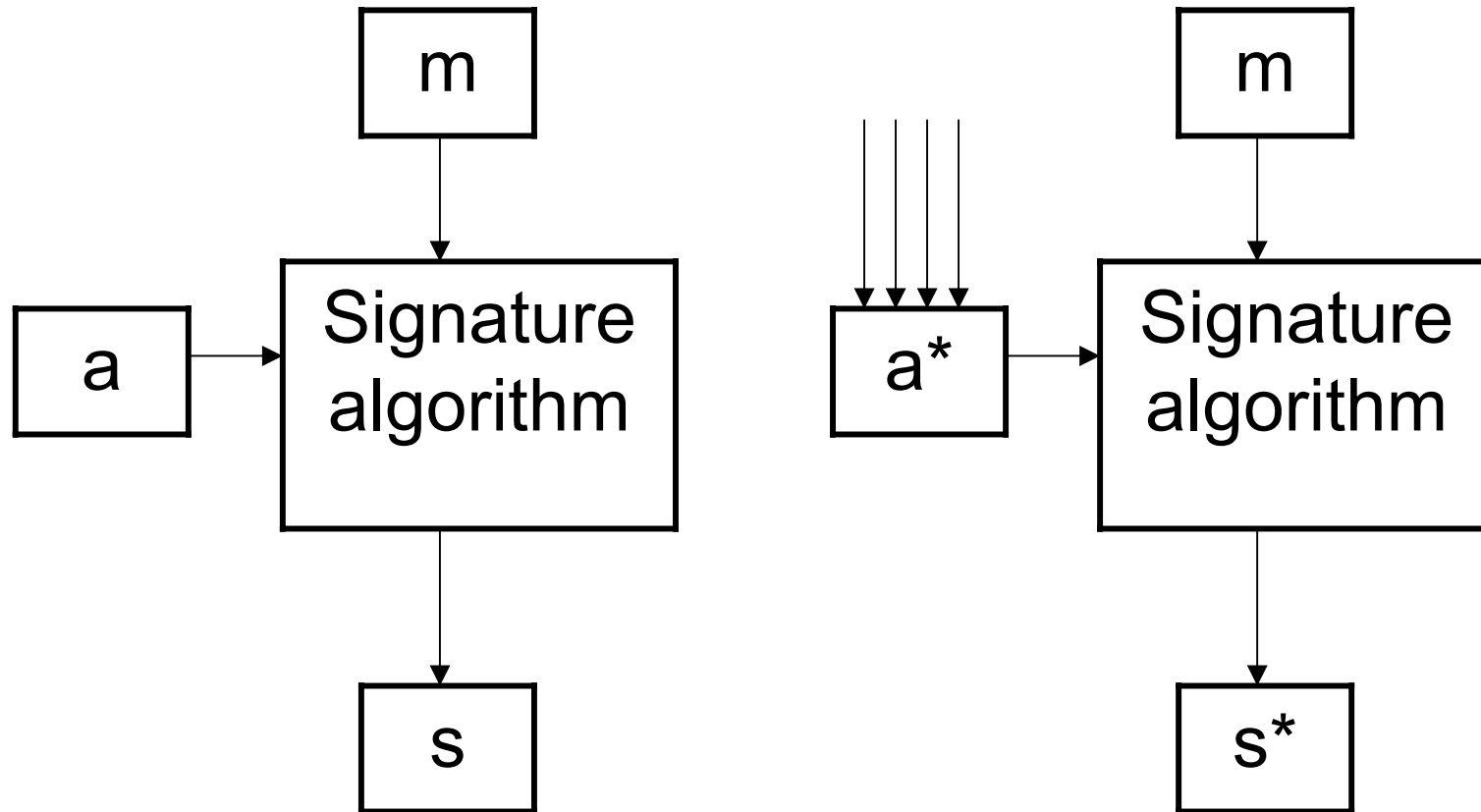
Contribution

- Extension of the bit-fault model of Bao et. al.
- Attacks on DSA, ElGamal and Schnorr (in this presentation only DSA)
- Upper bound for number of faulty signatures

Byte fault model

- Weaker assumption than bit-fault
- Easier to put into practice
- Bit-faults have been reported but better chips are being manufactured

Fault attacks



Strategy

- Induce a fault on one byte of the key
- Find the difference between the correct and the faulty byte in the key
- Restrict the number of possible values for each byte of the key to at most n
- Retrieve the key by exhaustive search among n^m candidates ($m = \text{\#bytes in key}$)

DSA-parameters

- Public parameters: (p, q, g)
- Primes: q 160-bit, p 1024-bit
- Base point: $1 < g \leq p-1$, $g^q \equiv 1 \pmod{p}$
- Private key: $1 \leq a \leq q-1$ (20 bytes)
- Public key: $A = g^a \pmod{p}$

DSA-signature

- hash of message: h
- random: $1 \leq k \leq q-1$
- $r = (g^k \bmod p) \bmod q$
- $s = k^{-1}(h+ar) \bmod q$
- Signature of message: (r,s)

DSA-verification

- hash of message: h
- $b = A^{r/s} \bmod p = g^{ar/s} \bmod p$
- $c = g^{h/s} \bmod p$
- $T = bc \bmod p \bmod q$
- Accept iff $T=r$

Erroneous key

- $a^* = a + e_{i,j}$
- $e_{i,j} = j \cdot 2^{8i}$, $0 \leq i \leq 19$, $-255 \leq j \leq 255$
- (r, s^*) , $s^* = k^{-1}(h + a^*r) \bmod q$
- First task: determine $e_{i,j}$

A useful value

- $b = A^{r/s^*} = g^{ar/s^*}$, $c = g^{h/s^*}$
- $T = bc \bmod p \bmod q$ (DSA-verification)
- $T = g^{(h+ar)/s^*} \bmod p \bmod q$
- $R_{i,j} = g^{e_{i,j} \cdot r/s^*} \bmod p \bmod q$
- $TR_{i,j} = g^{(h+r(a+e_{i,j}))/s^*} \bmod p \bmod q$
 $= g^{k(h+r(a+e_{i,j})) / (h+ra^*)} \bmod p \bmod q$

How do we pin-point the error?

- $TR_{i,j} = g^{k(h+r(a+e_{i,j})) / (h+ra^*)} \pmod p \pmod q$
 $= g^{kf_{i,j}} \pmod p \pmod q$
- $f_{i,j} = (h+r(a+e_{i,j})) / (h+ra^*)$
- $f_{i,j} = 1$ iff $a+e_{i,j} = a^*$
- $a^* = a+e_{i,j}$ iff $TR_{i,j} = r \pmod p \pmod q$

The faulty byte

- i 'th byte of the key: $e = a_i^* - a_i$
- bytes: $0 \leq a_i^*, a_i \leq 255$
- range for e : $-a_i \leq e \leq 255 - a_i$
- range for a_i : $-e \leq a_i \leq 255 - e$

A sufficient condition

$$256-n \leq e(s)-e(t)$$

restricts a_i to at most n values:

- $\forall e: -e \leq a_i \leq 255-e$
- $-e(t)$ $\leq a_i \leq 255-e(s) \leq$ $(n-1)-e(t)$

How many faults do we need?

Define T_n as:

$$\min\{ t \geq 2 \mid \exists 1 \leq s < t : |e(t)-e(s)| \geq 256-n \}$$

Two assumptions:

1. Faults are mutually independent
2. $\forall e: \text{Prob}(e) = 1 / 256$

Theoretical Result

- $p = 1 / 256$
- $P(T_n \leq t) = 1 - (n+1)(1-np)^t + n(1-(n+1)p)^t$
- $E[T_n] = (2n+1) / (np(n+1))$

Upper bound

Av. number of faulty signatures	App. number of keys left
7680	1
4267	2^{20}
2987	2^{32}
2304	2^{40}

Idea of proof

for $1 \leq j \leq n$ define events C_j :

“with t faulty signatures we have observed
 $e = -a_i+j-1$ and $255-a_i-n+j \leq e' \leq 255-a_i$ ”

$$\{T_n \leq t\} = C_1 \cup \dots \cup C_n$$

Inclusion-Exclusion Principle

$$\begin{aligned} P(T_n \leq t) &= P(C_1 \cup \dots \cup C_n) \\ &= \sum (-1)^{k+1} \sum P(\cap C_i) \end{aligned}$$

- and lots of calculations...

Conclusion

- Byte fault models are feasible
- At most 2304 faulty signatures to break DSA